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2N5771/FTSO5771

PNP Ultra High Speed Saturated Logic Switch

VCEO ... 15 V (Min)

ton ... 15 ns (Max) @ 10 mA, toll ... 20 ns (Max) @ 10 mA

PACKAGE 2N5771

TO-92

τ_s ... 20 ns (Max) @ 10 mA

FTSO5771

TO-236AA/AB

Complements ... 2N5769, 2N5772

ABSOLUTE MAXIMUM RATINGS (Note 1)

Temperatures

Storage Temperature

-55° C to 150° C

Operating Junction Temperature

150° C

Power Dissipation (Notes 2 & 3)

Total Dissipation at

2N

25° C Ambient Temperature

0.625 W 0.350 W*

FTSO

25° C Case Temperature

1.0 W

Voltages & Currents

V_{CEO} Collector to Emitter Voltage

-15 V

(Note 4)

Collector to Base Voltage Emitter to Base Voltage V_{EBO}

~15 V ~4.5 V

Collector Current

50 mA

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
BV _{CEO}	Collector to Emitter Breakdown Voltage (Note 5)	-15		V	I _C = 3.0 mA, I _B = 0
BV _{CES}	Collector to Emitter Breakdown Voltage	-15		V	$I_{C} = 100 \ \mu A, \ V_{BE} = 0$
ВУсво	Collector to Base Breakdown Voltage	-15		V	$I_{C} = 100 \ \mu A, I_{E} = 0$
BVEBO	Emitter to Base Breakdown Voltage	-4.5		V	$I_E = 100 \ \mu A, I_C = 0$
Ісво	Collector to Base Cutoff Current		10	nA	V _{CB} =8.0 V, I _C = 0
I _{EBO}	Emitter Cutoff Current		1.0	μА	V _{EB} = -4.5 V, I _C = 0
ICES	Collector Reverse Current		10 5.0	ΠΑ <i>μ</i> Α	$V_{CE} = -8.0 \text{ V}, V_{BE} = 0$ $V_{CE} = -8.0 \text{ V}, V_{BE} = 0, T_A = 125^{\circ}C$
h⊧€	DC Current Gain (Note 5)	35 50 40 20	120		$I_C = 1.0 \text{ mA}, V_{CE} = -0.5 \text{ V}$ $I_C = 10 \text{ mA}, V_{CE} = -0.3 \text{ V}$ $I_C = 50 \text{ mA}, V_{CE} = -1.0 \text{ V}$ $I_C = 10 \text{ mA}, V_{CE} = -0.3 \text{ V}, T_A = 55^\circ$

These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.

These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations

These ratings give a maximum junction temperature of 150°C and (TO-92) junction-to-case thermal resistance of 125°C/W (derating factor of 8.0 mW/°C); Junction-to-ambient thermal resistance of 200° C/W (derating factor of 5.0 mW/°C); (TO-236) junction-to-ambient thermal resistance of 357° C/W (derating factor of 2.8 mW/°C).

Rating refers to a high current point where collector to emitter voltage is lowest

Pulse conditions: length = 300 µs; duty cycle = 1%.

For product family characteristic curves, refer to Curve Set T292.

Package mounted on 99.5% alumina 8 mm x 8 mm x 0.6 mm,

NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

Quality Semi-Conductors

2N5771/FTSQ5771

ELECTRICAL CHARACTERISTICS (25° C Ambient Temperature unless otherwise noted) (Note 6)

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SYMBOL	CHARACTERISTIC	MIN	MAX	UNITS	TEST CONDITIONS
Vcetsati	Collector to Emitter Saturation Voltage (Note 5)		-0.18 -0.15 -0.6	>>>	$I_{C} = 10$ mA, $I_{B} = 1.0$ mA $I_{C} = 1.0$ mA, $I_{B} = 0.1$ mA $I_{C} = 50$ mA, $I_{B} = 5.0$ mA
VBE(SRI)	Base to Emitter Saturation Voltage (Note 5)	-0.8	-0.8 -0.95 -1.5	V V	I _C = 1.0 mA, I _B = 0.1 mA I _C = 10 mA, I _B = 1.0 mA I _C = 50 mA, I _B = 5.0 mA
Ссь	Collector to Base Capacitance		3.0	ρF	V _{CB} = -5.0 V, I _E = 0, f = 140 kHz
Ceb	Emitter to Base Capacitance		3.5	ρF	V _{EB} = -0.5 V, I _C = 0, f = 140 kHz
hte	High Frequency Current Gain	8.5			$I_c = 10 \text{ mA}, V_{ce} = -10 \text{ V}, f = 100 \text{ MH}$
ton	Turn On Time (test circuit no 348)		15	กร	I _C = 10 mA, I _{B1} = 1.0 mA
toff	Turn Off Time (test circuit no 348)		20	ns	$I_0 = 10 \text{ mA}, I_{B1} = I_{B2} = 1.0 \text{ mA}$
78	Charge Storage Time Constant (test circuit no. 234)		20	ns	I _C = 10 mA, I _{B1} ≈ I _{B2} ≈ 10 mA

